

# LTE RADIO TEST REPORT

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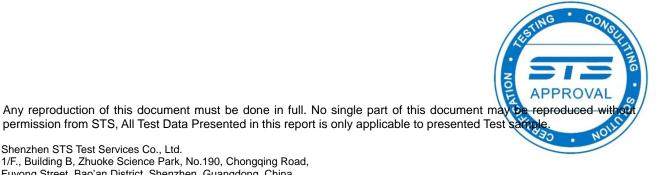
# Report No: STS1801226W02

Issued for

**ITALCOM GROUP** 

1728 Coral Way, Coral Gables, Miami, Florida, United States 33145(Zip code : 518048)

Product Name:	4G LTE
Brand Name:	NYX
Model Name:	ICE
Series Model:	N/A
FCC ID:	YPVITALCOMICE
Test Standard:	47 CFR Part 2, 27





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# **TEST RESULT CERTIFICATION**

Applicant's name	ITALCOM GROUP
Address	1728 Coral Way,Coral Gables,Miami,Florida,United States 33145(Zip code : 518048)
Manufacture's Name	Shenzhen qianhai aibo Science and Technology Ltd.
Address	room 303, Ling Nan building, NO.3081, Qiaoxiang Road, Fu- tian District,Shenzhen city, Guangdong Province, China
Product description	
Product Name:	4G LTE
Brand Name	NYX
Model Name	ICE
Series Model	N/A
Test Standards	47 CFR Part 2, 27
Test procedure	: ANSI / TIA 603-D-2010

This device described above has been tested by STS and the test results show that the equipment under test (EUT) is in compliance with the FCC requirements. And it is applicable only to the tested sample identified in the report.

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Date of Test

Date of performance of tests ...... 22 Jan. 2018~29 Jan. 2018

Date of Issue...... 02 Feb. 2018

Test Result..... Pass

**Testing Engineer** (Chris chen) Technical Manager : (Sean she) Authorized Signatory :

(Vita Li)

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# **Revision History**

Rev.	Issue Date	Report NO.	Effect Page	Contents
00	02 Feb. 2018	STS1801226W02	ALL	Initial Issue



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 TEST FACTORY & MEASUREMENT UNCERTAINTY
 1.1.1 TEST FACTORY
 Shenzhen STS Test Services Co., Ltd.
 Add.: 1/F., Building B, Zhuoke Science Park, No.190, Chongqing Road, Fuyong Street, Bao'an District, Shenzhen, Guangdong, China
 CNAS Registration No.: L7649; FCC Registration No.: 625569
 IC Registration No.: 12108A; A2LA Certificate No.: 4338.01;

# **1.1.2 MEASUREMENT UNCERTAINTY**

The reported uncertainty of measurement  $\mathbf{y} \pm \mathbf{U}$  where expended uncertainty  $\mathbf{U}$  is based on a standard uncertainty multiplied by a coverage factor of **k=2** · providing a level of confidence of approximately **95** % °

No.	Item	Uncertainty
3	RF power, conducted	±0.71dB
5	All emissions, radiated (<1G) 30MHz-200MHz	±2.83dB
6	All emissions,radiated(<1G) 200MHz-1000MHz	±2.94dB
7	All emissions, radiated (>1G)	±3.03dB





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# 2. GENERAL INFORMATION

# 2.1 TECHNICAL SPECIFICATIONS AND REGULATIONS

# 2.1.1 PRODUCT DESCRIPTION

A major technical description of EUT is described as following:

Product Name:	4G LTE						
Hardware version:	NYX_ICE_001						
Software version:	ICE_AMXNYX_V001R						
FCC ID:	YPVITALCOMICE						
Frequency Bands:	U.S. Bands: LTE FDD Band 2  LTE FDD Band 4 LTE FDD Band 5: LTE FDD Band 7: LTE FDD Band 12: LTE FDD Band 13: LTE FDD Band 17:						
SIM CARD:	Only support single SIM Card.						
Antenna:	PIFA Antenna						
Antenna gain:	LTE Band 4: -1dBi						
Power Supply:	DC 3.7V by battery						
Battery parameter:	Capacity: 2000mAh, Rated Voltage: 3.7V						
Adapter Input:	AC100-240V, 50-60Hz, 150mA						
Adapter Output:	DC 5V, 1000mA						

2.1.2 PRODUCT SPECIFICATION SUBJECTIVE TO THIS STANDARD

Product Specification Subjective To This Standard							
<b>Tx Frequency</b> LTE Band 4:1710~1755MHz							
Rx Frequency         LTE Band 4:2110~2155MHz							
BandwidthLTE Band 4 : 1.4MHz / 3MHz / 5MHz / 10MHz / 15MHz /20MHz							
Maximum Output     LTE Band 4 : 23.64 dBm							
Type of Modulation	QPSK / 16QAM						



# 2.1.3 EMISSION DESIGNATOR

LTE Band 4 BW(MHz)	Emission Designator (26dBc)QPSK	Emission Designator (26dBc)16QAM
1.4	1M31G7D	1M33W7D
3	2M95G7D	2M95W7D
5	5M04G7D	5M05W7D
10	9M76G7D	9M69W7D
15	14M7G7D	14M7W7D
20	19M3G7D	19M4W7D



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# 2.1.4 TEST CONFIGURATION OF EQUIPMENT UNDER TEST

Antenna port conducted and radiated test items listed below are performed according to KDB 971168 D02 Power Meas. License Digital Systems with maximum output power.Radiated measurements are performed by rotating the EUT in three different orthogonal test planes tofind the maximum emission.

Remark:

- 1. The mark "v " means that this configuration is chosen for testing
- 2. The mark "-" means that this bandwidth is not supported.
- 3. The device is investigated from 30MHz to 10 times of fundamental signal for radiated

ITEMS	Band	В	and	dwid	dth (	MH	z)	Modul	lation		RB #			Test hanr	
		1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full	L	Μ	Н
Max. Output Power	4	v	v	v	v	v	v	v	v	v	v	v	v	v	v
Peak&Avera Ratio	4						v	v	v	v		v	v	v	v
26dB&99% Bandwidth	4	v	v	v	v	v	V	v	×			v	v	v	v
Conducted Band Edge	4	v	v	v	v	v	v	v	v	v		v	v	v	v
Conducted Spurious Emission	4	v	v	v	v	v	v	v	v	v			v	v	v
Frequency Stability	4	/			v			v				v		v	
E.R.P.& E.I.R.P.	4	v	v	v	v	v	v	v	v	v			v	v	v
Radiated Spurious Emission	4	v	v	v	v	v	v	v		v			v	v	v



# 2.1.5 RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is intended for filing to comply with the 47 CFR Part 2, 27

# 2.1.6 SPECIAL ACCESSORIES

The battery and the charger, earphone supplied by the applicant were used as accessories and being tested with eut intended for fcc grant together.

# 2.1.7 EUT CONFIGURATION

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

# 2.1.8 EUT EXERCISE

The Transmitter was operated in the maximum output power mode through Communication Tester. The TX frequency was fixed which was for the purpose of the measurements.





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# 2.1.9 CONFIGURATION OF EUT SYSTEM

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

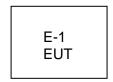


Table 2-1 Equipment Used in EUT System

Item	Equipment	Model No.	Serial No.	Note

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in  $\[$ <sup> $\Gamma$ </sup>Length  $\]$  column.

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# 2.1.10 MEASUREMENT INSTRUMENTS

The radiated emission testing was performed according to the procedures of ansi ANSI / TIA 603-D-2010 and FCC CFR 47 rules of 2.1046, 2.1047, 2.1049, 2.1051, 2.1053, 2.1055, 2.1057.

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibra- tion	Calibrated Until
Test Receiver	R&S	ESCI	101427	2017.10.15	2018.10.14
Wireless Communica- tions Test Set	R&S	CMW 500	133884	2016.10.23	2017.10.22
Bilog Antenna	TESEQ	CBL6111D	34678	2017.03.24	2018.03.23
Horn Antenna	Schwarzbeck	BBHA 9120D (1201)	9120D-1343	2017.03.06	2018.03.05
MXA SIGNAL Analyzer	Agilent	N9020A	MY49100060	2017.03.11	2018.03.10
Low frequency cable	N/A	R01	N/A	NCR	NCR
High frequency cable	SCHWARZBECK	SCHWARZBECK AK9515H SN-96286/96287		NCR	NCR
Signal Generator	Agilent	N5182A	MY46240556	2017.10.15	2018.10.14
Pre-mplifier (0.1M-3GHz)	EM	EM330	60538	2017.03.12	2018.03.11
PreAmplifier (1G-26.5GHz)	Agilent	8449B	60538	2017.10.15	2018.10.14
Temperature& Humidity test chamber	GZGONGWEN	GDS-250	080821	2017.10.15	2018.10.14
Band Reject fil- ter(1920-1980MHz)	COM-MW	ZBSF-1920-1980	0092	2017.10.15	2018.10.14
Band Reject fil- ter(880-915MHz)	COM-MW	ZBSF-C897.5-35	707	2017.10.15	2018.10.14
Band Reject fil- ter(1710-1785MHz)	COM-MW	ZBSF-C1747.5-75	708	2017.10.15	2018.10.14
Band Reject fil- ter(1850-1910MHz)	COM-MW	ZBSF-C1880-60	709	2017.10.15	2018.10.14
Band Reject fil- ter(2500-2570MHz)	COM-MW	ZBSF-C2535-70	710	2017.10.15	2018.10.14
Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	2017.10.15	2018.10.14

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# 2. 1.11 MEASUREMENT RESULTS EXPLANATION EXAMPLE

For all conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss and attenuator factorbetween EUT conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level is exactly the EUT RF output level.

The spectrum analyzer offset is derived from RF cable loss and attenuator factor.

Offset = RF Cable Loss + Attenuator Factor.



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# 3. CONDUCTED OUTPUT POWER

#### 3.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

#### 3.1.1 MEASUREMENT METHOD

A System Simulator Was Used To Establish Communication With The EUT. Its Parameters Were Set To Force The EUT Transmitting At Maximum Output Power. The Measured Power In The Radio Frequency On The Transmitter Output Terminals Shall Be Reported. configuration follows KDB 971168 D01.

#### 3.1.2 TEST SETUP



#### 3.1.3 TEST PROCEDURES

- 1. The Transmitter Output Port Was Connected To The System Simulator.
- 2. Set EUT at maximum power through the system simulator.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure and record the power level from the system simulator.



# 3.1.4 TEST RESULTS

# LTE BAND 4

LTE Band 4 Maximum Average Power [dBm]									
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest			
1.4	1	0		22.46	22.48	22.62			
1.4	1	2		22.47	22.51	22.56			
1.4	1	5		22.07	22.37	22.77			
1.4	3	0	QPSK	21.77	22.35	22.72			
1.4	3	1		21.84	22.36	22.7			
1.4	3	2		21.76	22.34	22.64			
1.4	6	0		21.94	22.01	22.09			
1.4	1	0		21.83	22.23	22.3			
1.4	1	2		21.87	22.19	22.23			
1.4	1	5		20.91	22.23	22.21			
1.4	3	0	16-QAM	22.48	22.41	22.32			
1.4	3	1		22.51	22.39	22.2			
1.4	3	2		22.37	22.39	22.16			
1.4	6	0		22.35	20.76	20.66			
3	1	0		22.49	22.43	22.67			
3	1	7		22.45	22.45	22.61			
3	1	14		22.63	22.53	22.46			
3	8	0	QPSK	21.94	21.86	22.13			
3	8	4		21.91	21.98	22.2			
3	8	7		21.97	22.01	22.1			
3	15	0		21.89	21.93	22.18			
3	1	0		21.99	21.76	21.41			
3	1	7		21.81	21.68	21.57			
3	1	14		21.85	21.8	21.62			
3	8	0	16-QAM	21.16	20.64	21.05			
3	8	4		21.21	20.51	20.89			
3	8	7		21.32	20.53	20.8			
3	15	0		21.1	20.55	20.8			



LTE Band 4 Maximum Average Power [dBm]										
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest				
5	1	0		22.54	22.19	22.54				
5	1	12		22.49	22.24	22.53				
5	1	24		22.5	22.21	22.61				
5	12	0	QPSK	21.79	21.82	21.93				
5	12	6		21.92	21.83	22.09				
5	12	11		21.83	21.91	21.99				
5	25	0		21.83	21.83	22.08				
5	1	0		22.12	22.34	22.18				
5	1	12		22.18	22.28	22.17				
5	1	24		22.11	22.35	22.23				
5	12	0	16-QAM	20.84	20.55	21.17				
5	12	6		21.02	20.69	21.11				
5	12	11		21.05	20.51	20.87				
5	25	0		21.09	20.53	20.82				
10	1	0		22.24	22.37	22.47				
10	1	24		22.17	22.52	22.61				
10	1	49		22.26	22.54	22.6				
10	25	0	QPSK	21.88	21.84	22.04				
10	25	12		21.86	21.78	22.07				
10	25	24		21.77	21.81	22.11				
10	50	0		21.89	21.83	22.01				
10	1	0		22.18	21.95	22.04				
10	1	24		22.08	22.09	22.13				
10	1	49		22.15	22.11	22.09				
10	25	0	16-QAM	21.41	20.75	21.63				
10	25	12		21.35	20.72	21.38				
10	25	24		21.28	20.74	21.08				
10	50	0		21.24	20.84	21.34				

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LTE Band 4 Maximum Average Power [dBm]										
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest				
15	1	0		22.29	22.14	22.39				
15	1	37		22.2	22.38	22.5				
15	1	74		22.25	22.36	22.36				
15	36	0	QPSK	21.98	21.78	21.85				
15	36	18		21.88	21.91	22.01				
15	36	39		21.81	21.94	22.05				
15	75	0		21.86	21.94	21.96				
15	1	0		22.14	21.22	22.16				
15	1	38		21.96	21.31	22.27				
15	1	75		22.04	21.32	22.27				
15	36	0	16-QAM	21.12	20.72	21.04				
15	36	18		21	20.76	21.21				
15	36	39		20.85	20.83	21.16				
15	75	0		20.74	20.78	20.97				
20	1	0		23.13	23.03	23.01				
20	1	49		23.34	23.38	23.43				
20	1	99		22.94	23.24	23.64				
20	50	0	QPSK	22.64	23.22	23.59				
20	50	24		22.71	23.23	23.57				
20	50	49		22.63	23.21	23.51				
20	100	0		22.81	22.88	22.96				
20	1	0		23.12	23.34	23.25				
20	1	49		22.43	22.75	22.79				
20	1	99		21.47	22.79	22.77				
20	50	0	16-QAM	23.04	22.97	22.88				
20	50	24		23.07	22.95	22.76				
20	50	49		22.93	22.95	22.72				
20	100	0		22.91	21.32	21.22				

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# 4. PEAK-TO-AVERAGE RATIO

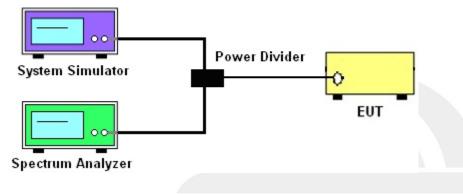
4.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

#### 4.1.1 MEASUREMENT METHOD

Use one of the procedures presented in 4.1 to measure the total peak power and record as PPk. Use one of the applicable procedures presented 4.2 to measure the total average power and record as PAvg. Both the peak and average power levels must be expressed in the same logarithmic units (e.g., dBm). Determine the PAPR from:

PAPR (dB) = PPk (dBm) - PAvg (dBm).

4.1.2 TEST SETUP



# 4.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 v02r02 Section 5.7.2..
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the peak and average power of the spectrum analyzer
- 5. Record the deviation as Peak to Average Ratio.

	LTE								
LTE BW	1.4M	3M	5M	10M	15M	20M			
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz			
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz			
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz			
Detector	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG			
Trace	Max	Max	Max	Max	Max	Max			
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto			



# 4.1.4 TEST RESULTS

# LTE BAND 4

	LTE Band 4 PAR [dBm]												
BW	RB	Modulation		Lowest		Middle			Highest				
[MHz]	Size	Modulation	PEAK	AVG	P-A	PEAK	AVG	P-A	PEAK	AVG	P-A		
20	1	QPSK	29.09	23.13	5.96	28.97	23.03	5.94	28.93	23.01	5.92		
20	100	QPSK	28.6	22.81	5.79	28.66	22.88	5.78	28.92	22.96	5.96		
20	1	16 0 0 0	28.84	23.12	5.72	29.25	23.34	5.91	29.04	23.25	5.79		
20	100	16-QAM	28.73	22.91	5.82	27.1	21.32	5.78	28.79	22.96	5.83		
	Limit			≤13dBm									



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# 5. RADIATED POWER AND EFFECTIVE ISOTROPIC RADIATED POWER

# 5.1 DESCRIPTION OF THE ERP/EIRP MEASUREMENT

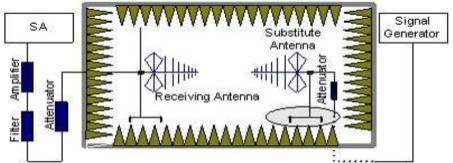
# 5.1.1 MEASUREMENT METHOD

Effective radiated power output measurements by substitution method according to ANSI / TIA / EIA-603-D, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas. License Digital Systems. Mobile and portable (hand-held) stations operating are limited to average ERP,Equivalent isotropic radiated power output measurements by substitution method according to ANSI /TIA / EIA-603-D, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas. D01 Power Meas ,Mobile and portable (hand-held) stations operating are limited to average ERP,Equivalent isotropic radiated power output measurements by substitution method according to ANSI /TIA / EIA-603-D, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas ,Mobile and portable (hand-held) stations operating are limited to average EIRP.

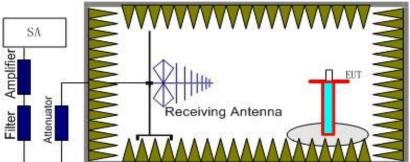
# 5.1.2 TEST SETUP

The procedure of radiated spurious emissions is as follows:

a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx( dBuV )+CL( dB )+SA( dB )+Gain( dBi )-107( dBuV to dBm )The SA is calibrated using following setup.



b) EUT was placed on a 1.5 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic were measured with peak detector and 1MHz bandwidth.



Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Pow-

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#### 5.1.3 TEST PROCEDURES

1. The testing follows FCC KDB 971168 v02r02 Section 5.6. and ANSI / TIA-603-D-2010 Section 2.2.17.

2. The EUT was placed on a non-conductive rotating platform 1.5 meters high in a semi-anechoic chamber. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and a spectrum analyzer with Peak detector.

3. During the measurement, the system simulator parameters were set to force the EUTtransmitting at maximum output power. The maximum emission was recorded from analyzer power level (LVL) from the 360 degrees rotation of the turntable and the test antenna raised and lowered over a range from 1 to 4 meters in both horizontally and vertically polarized orientations.

4. Effective Isotropic Radiated Power (EIRP) was measured by substitution method according to-TIA/EIA-603-D. The EUT was replaced by dipole antenna (substitution antenna) at same location, and then a known power from S.G. was applied into the dipole antenna through a Tx cable, and then recorded the maximum Analyzer reading through raised and lowered the test antenna. The correction factor (in dB) = S.G. - Tx Cable loss + Substitution antenna gain -Analyzer reading. Then the EUT's EIRP was calculated with the correction factor, EIRP= LVL +Correction factor and ERP = EIRP – 2.15.

5.RB Set greater than bandwidth, Vb Set spectrum analyzer Maximum support.





# 5.1.4 TEST RESULTS

# LTE Band 4

			Radi	ated Power (	(EIRP) for L	TE Band 4 /	1.4M			
		1				Result				
Modulation	ŀ	RB	Channel	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion	
Woddiation	Size Of	Offset	Ondriner	(dBm)	loss	(dBi)	E.R.P(dBm)	Of Max.	Conclusion	
	Size	Oliset		(dbiii)	1000	(abi)		ERP		
	1	0	Lowest	12.2	2.35	10.13	19.98	Horizontal	Pass	
	1	0	Middle	14.15	2.36	10.16	21.95	Vertical	Pass	
QPSK	1	0	Highest	12.33	2.37	10.22	20.18	Horizontal	Pass	
QFON	1	0	Lowest	14.14	2.35	10.13	21.92	Vertical	Pass	
	1	0	Middle	12.41	2.36	10.16	20.21	Horizontal	Pass	
	1	0	Highest	14.24	2.37	10.22	22.09	Vertical	Pass	
	1	0	Lowest	12.31	2.35	10.13	20.09	Horizontal	Pass	
	1	0	Middle	14.14	2.36	10.16	21.94	Vertical	Pass	
16QAM	1	0	Highest	12.11	2.37	10.22	19.96	Horizontal	Pass	
TOQAIVI	1	0	Lowest	14.11	2.35	10.13	21.89	Vertical	Pass	
	1	0	Middle	12.36	2.36	10.16	20.16	Horizontal	Pass	
	1	0	Highest	13.99	2.37	10.22	21.84	Vertical	Pass	
Limit	EIRP<1W=30dBm									

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	Radiated Power (EIRP) for LTE Band 4 / 3M												
		RΒ				Result							
Modulation	Г	λD	Channel	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion				
Modulation	Size	Offset	Channer	(dBm) loss	(dBi)	E.R.P(dBm)	Of Max.	COnclusion					
		Oliset				(UDI)		ERP					
	1	0	Lowest	12.47	2.35	10.13	20.25	Horizontal	Pass				
	1	0	Middle	14.17	2.36	10.16	21.97	Vertical	Pass				
QPSK	1	0	Highest	12.27	2.37	10.22	20.12	Horizontal	Pass				
QFOR	1	0	Lowest	14.11	2.35	10.13	21.89	Vertical	Pass				
	1	0	Middle	12.38	2.36	10.16	20.18	Horizontal	Pass				
	1	0	Highest	14.28	2.37	10.22	22.13	Vertical	Pass				
	1	0	Lowest	12.48	2.35	10.13	20.26	Horizontal	Pass				
	1	0	Middle	14.09	2.36	10.16	21.89	Vertical	Pass				
16QAM	1	0	Highest	12.32	2.37	10.22	20.17	Horizontal	Pass				
TOQAM	1	0	Lowest	13.83	2.35	10.13	21.61	Vertical	Pass				
	1	0	Middle	12.54	2.36	10.16	20.34	Horizontal	Pass				
	1	0	Highest	14.14	2.37	10.22	21.99	Vertical	Pass				
Limit	EIRP<	EIRP<1W=30dBm											

			Rad	iated Power	(EIRP) for L	TE Band 4	/ 5M				
	-	חר	1		Result						
Modulation	RB		Channel	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion		
Modulation		Offset	Channel	(dBm) loss	(dBi)	E.R.P(dBm)	Of Max.	Conclusion			
	Size	Oliset			(UDI)		ERP				
	1	0	Lowest	12.35	2.35	10.13	20.13	Horizontal	Pass		
	1	0	Middle	14.21	2.36	10.16	22.01	Vertical	Pass		
QPSK	1	0	Highest	11.89	2.37	10.22	19.74	Horizontal	Pass		
QLOK	1	0	Lowest	13.87	2.35	10.13	21.65	Vertical	Pass		
	1	0	Middle	12.44	2.36	10.16	20.24	Horizontal	Pass		
	1	0	Highest	14.17	2.37	10.22	22.02	Vertical	Pass		
	1	0	Lowest	12.4	2.35	10.13	20.18	Horizontal	Pass		
	1	0	Middle	14.02	2.36	10.16	21.82	Vertical	Pass		
16QAM	1	0	Highest	11.87	2.37	10.22	19.72	Horizontal	Pass		
IUGAM	1	0	Lowest	13.63	2.35	10.13	21.41	Vertical	Pass		
	1	0	Middle	12.33	2.36	10.16	20.13	Horizontal	Pass		
	1	0	Highest	14.12	2.37	10.22	21.97	Vertical	Pass		
Limit	EIRP<	IRP<1W=30dBm									

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# Report No.: STS1801226W02

	Radiated Power (EIRP) for LTE Band 4 / 10M												
		RB				Result							
Modulation	Г	(D		S G.Level	Cable	Gain	PMeas	Polarization	Conclusion				
Modulation	0ine	04004	Channel					Of Max.	Conclusion				
	Size	Offset		(dBm)	loss	(dBi)	E.R.P(dBm)	ERP					
	1	0	Lowest	12.11	2.35	10.13	19.89	Horizontal	Pass				
	1	0	Middle	13.88	2.36	10.16	21.68	Vertical	Pass				
QPSK	1	0	Highest	11.98	2.37	10.22	19.83	Horizontal	Pass				
QFSK	1	0	Lowest	14.01	2.35	10.13	21.79	Vertical	Pass				
	1	0	Middle	12.37	2.36	10.16	20.17	Horizontal	Pass				
	1	0	Highest	14.09	2.37	10.22	21.94	Vertical	Pass				
	1	0	Lowest	12.1	2.35	10.13	19.88	Horizontal	Pass				
	1	0	Middle	13.78	2.36	10.16	21.58	Vertical	Pass				
16QAM	1	0	Highest	12.13	2.37	10.22	19.98	Horizontal	Pass				
TOQAIM	1	0	Lowest	13.82	2.35	10.13	21.60	Vertical	Pass				
-	1	0	Middle	12.32	2.36	10.16	20.12	Horizontal	Pass				
	1	0	Highest	13.97	2.37	10.22	21.82	Vertical	Pass				
Limit	EIRP<	EIRP<1W=30dBm											

			Rad	iated Power	(EIRP) for L	TE Band 4 /	15M				
	RB				Result						
Modulation			Charge	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion		
Modulation	Size Offset	Offset	Channel	(dBm)	loss	(dBi)	E.R.P(dBm)	Of Max.	COnclusion		
		Oliset		(UBIII)			ERP				
	1	0	Lowest	12.23	2.35	10.13	20.01	Horizontal	Pass		
	1	0	Middle	13.92	2.36	10.16	21.72	Vertical	Pass		
QPSK	1	0	Highest	11.76	2.37	10.22	19.61	Horizontal	Pass		
QFOR	1	0	Lowest	13.8	2.35	10.13	21.58	Vertical	Pass		
	1	0	Middle	12.23	2.36	10.16	20.03	Horizontal	Pass		
	1	0	Highest	14.01	2.37	10.22	21.86	Vertical	Pass		
	1	0	Lowest	12.09	2.35	10.13	19.87	Horizontal	Pass		
	1	0	Middle	13.74	2.36	10.16	21.54	Vertical	Pass		
16QAM	1	0	Highest	11.78	2.37	10.22	19.63	Horizontal	Pass		
TOQAIN	1	0	Lowest	13.65	2.35	10.13	21.43	Vertical	Pass		
	1	0	Middle	12.13	2.36	10.16	19.93	Horizontal	Pass		
	1	0	Highest	13.86	2.37	10.22	21.71	Vertical	Pass		
Limit	EIRP<	EIRP<1W=30dBm									

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			Rad	iated Power	(EIRP) for L	TE Band 4 /	20M			
	r	RB			Result					
Modulation	г	(D	Observat	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion	
wouldition	Size	Offset	Channel		loss	(dBi)	E.R.P(dBm)	Of Max.	Conclusion	
	Size	Oliset			1055	(UDI)	E.R.F(UDIII)	ERP		
	1	0	Lowest	13.12	2.35	10.13	20.90	Horizontal	Pass	
	1	0	Middle	14.82	2.36	10.16	22.62	Vertical	Pass	
QPSK	1	0	Highest	12.71	2.37	10.22	20.56	Horizontal	Pass	
QFOR	1	0	Lowest	14.73	2.35	10.13	22.51	Vertical	Pass	
	1	0	Middle	12.64	2.36	10.16	20.44	Horizontal	Pass	
	1	0	Highest	14.49	2.37	10.22	22.34	Vertical	Pass	
	1	0	Lowest	12.87	2.35	10.13	20.65	Horizontal	Pass	
	1	0	Middle	14.68	2.36	10.16	22.48	Vertical	Pass	
16QAM	1	0	Highest	12.87	2.37	10.22	20.72	Horizontal	Pass	
TOQAIM	1	0	Lowest	14.51	2.35	10.13	22.29	Vertical	Pass	
	1	0	Middle	12.76	2.36	10.16	20.56	Horizontal	Pass	
	1	0	Highest	14.43	2.37	10.22	22.28	Vertical	Pass	
Limit	EIRP<1W=30dBm									

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# 6. OCCUPIED BANDWIDTH

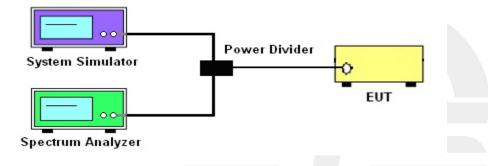
#### 6.1 DESCRIPTION OF OCCUPIED BANDWIDTH MEASUREMENT

#### 6.1.1 MEASUREMENT METHOD

1. The occupied bandwidth is the width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean transmitted power.

2. The 26 db emission bandwidth is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated 26 db below the maximum in-band spectral density of the modulated signal. spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth equal to approximately 1.0% of the emission bandwidth.

#### 6.1.2 TEST SETUP



# 6.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 v02r02 Section 4.1.and 4.2
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the Occupied Bandwidth of the spectrum analyzer
- 5. Measure and record the Occupied Bandwidth from the Spectrum Analyzer.

	LTE								
LTE BW	1.4M	1.4M 3M 5M 10M 15M							
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz			
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz			
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz			
Detector	PK	PK	PK	PK	PK	PK			
Trace	Max	Max	Max	Max	Max	Max			
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto			



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# 6.1.4 MEASUREMENT RESULT

# LTE BAND 4

	LTE Band 4 Bandwidth [MHz]											
BW [MHz]	Mod	Low	est	Mid	dle	Highest						
	INIOU	26dB BW	99% BW	26dB BW	99% BW	26dB BW	99% BW					
1.4	QPSK	1.298	1.0960	1.307	1.0966	1.309	1.1002					
1.4	16-QAM	1.294	1.0968	1.313	1.1029	1.331	1.1041					
3	QPSK	2.942	2.6828	2.932	2.6854	2.945	2.6907					
3	16-QAM	2.938	2.6894	2.930	2.6875	2.949	2.6846					
5	QPSK	5.040	4.5189	5.020	4.5265	5.040	4.5215					
5	16-QAM	5.008	4.5064	5.026	4.5302	5.051	4.5213					
10	QPSK	9.674	8.9230	9.712	8.9316	9.759	8.9411					
10	16-QAM	9.685	8.9298	9.665	8.9336	9.607	8.9126					
15	QPSK	14.66	13.448	14.66	13.444	14.74	13.433					
15	16-QAM	14.66	13.440	14.64	13.461	14.62	13.432					
20	QPSK	19.20	17.845	19.26	17.862	18.19	17.890					
20	16-QAM	19.30	17.830	17.899	19.35	19.25	17.872					

# **NOTE: Test chart See Appendix A**

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# 7. CONDUCTED BAND EDGE

#### 7.1 DESCRIPTION OF CONDUCTED BAND EDGE MEASUREMENT

#### 7.1.1 MEASUREMENT METHOD

#### 1. §22.917(a)

For operations in the 824 – 849 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100kHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

#### 2. §24.238 (a)

For operations in the 1850-1910 and 1930-1990 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1MHz bandwidth. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed

#### 3. §27.53 (h)

For operations in the 1710 – 1755 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1 MHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

# 4. §27.53(m)(4)

For operations in the 2500 MHz ~ 2570 MHz band this section, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licenseesoperating on frequencies below 2495 MHz may also submit a documented interference complaintagainst BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees.

# 5. §27.53 (g)

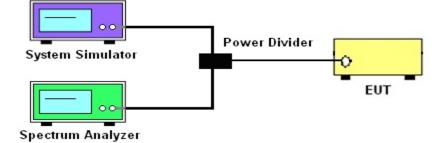
For operations in the 698 -746 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100 kHz bandwidth. However, in the 100 kilohertz bands immediately outside and adjacent to a licensee's frequency block, a resolution bandwidth of at least 30 kHz may be employed.

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# 7.1.2 TEST SETUP



# 7.1.3 TEST PROCEDURES

1.The testing FCC KDB 971168 D01 v02r02 Section 6.0. and ANSI/TIA-603-D-2010-Section 2.2.13.2(d)

2. The EUT was connected to spectrum analyzer and system simulator via a power divider.

3. The band edges of low and high channels for the highest RF powers were measured. Set RBW >= 1% EBW in the 1MHz band immediately outside and adjacent to the band edge.

4. Set spectrum analyzer with RMS/AVG detector

5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.

6.The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

= P(W) - [43 + 10log(P)] (dB)

```
= [30 + 10\log(P)] (dBm) - [43 + 10\log(P)] (dB)
```

= -13dBm.

Band 7:

= P(W) - [55 + 10log(P)] (dB)

```
= [30 + 10log(P)] (dBm) - [55 + 10log(P)] (dB)
```

= -25dBm.

	LTE							
LTE BW	1.4M	3M	5M	10M	15M	20M		
Span	12MHz	13MHz	15MHz	20MHz	25MHz	30MHz		
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz		
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz		
Detector	RMS	RMS	RMS	RMS	RMS	RMS		
Trace	Max	Max	Max	Max	Max	Max		
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto		

# 7.1.4 MEASUREMENT RESULT

NOTE: Test chart See Appendix B

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# 8. CONDUCTED SPURIOUS EMISSIO

# 8.1 DESCRIPTION OF CONDUCTED SPURIOUS EMISSION MEASUREMENT

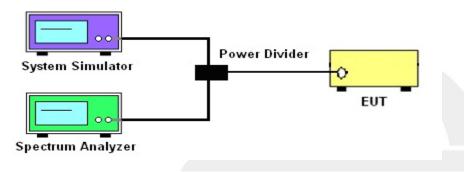
# 8.1.1 MEASUREMENT METHOD

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7:

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least  $55 + 10 \log (P) dB$ .

It is measured by means of a calibrated spectrum analyzer and scanned from 30 MHz up to a frequency including its 10th harmonic.

# 8.1.2 TEST SETUP



# 8.1.3 TEST PROCEDURES

1.The testing FCC KDB 971168 D01 v02r02 Section 6.0. and ANSI/TIA-603-D-2010-Section 2.2.13.2(d)

2. The EUT was connected to spectrum analyzer and system simulator via a power divider.

3. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement

4. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.

5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.

6.The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

= P(W) - [43 + 10log(P)] (dB) = [30 + 10log(P)] (dBm) - [43 + 10log(P)] (dB)

= -13dBm.

For Band 7:P(W)- [43 + 10log(P)] (dB) =-25dBm

	LTE								
LTE BW	1.4M	3M	5M	10M	15M	20M			
Span	Auto	Auto	Auto	Auto	Auto	Auto			
RBW	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz			
VBW	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz			
Detector	PK	PK	PK	PK	PK	PK			
Trace	Max	Max	Max	Max	Max	Max			

8.1.4 TEST RESULTS NOTE:Test chart See Appendix C

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# 9. RADIATED SPURIOUS EMISSION

# 9.1 DESCRIPTION OF RADIATED SPURIOUS EMISSION

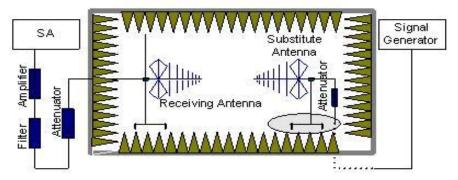
# 9.1.1 MEASUREMENT METHOD

The radiated spurious emission was measured by substitution method according to ANSI / TIA / EIA-603-D-2010. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7 The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 55 + 10 log (P) dB. For Band. The spectrum is scanned from 30 MHz up to a frequency including its 10th harmonic.

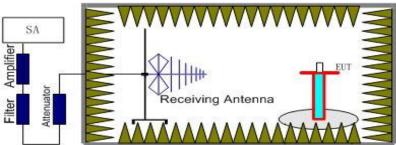
# 5.1.2 Test Setup

The procedure of radiated spurious emissions is as follows:

a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx ( dBuV ) +CL ( dB ) +SA ( dB ) +Gain ( dBi ) -107 ( dBuV to dBm ) The SA is calibrated using following setup.



b) EUT was placed on a 1.5 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic were measured with peak detector and 1MHz bandwidth.



Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Pow-er=PMea+ARpl

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#### 9.1.3 TEST PROCEDURES

1. The testing FCC KDB 971168 D01 Section 5.8 and ANSI/TIA-603-D-2010-Section 2.2.12.2(b)

2. The EUT was placed on a rotatable wooden table with 0.8 meter above ground.

3. The EUT was set 3 meters from the receiving antenna, which was mounted on the antenna tower.

4. The table was rotated 360 degrees to determine the position of the highest spurious emission.

5. The height of the receiving antenna is varied between one meter and four meters to search the maximum spurious emission for both horizontal and vertical polarizations
6. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the

record of maximum spurious emission.

7. A horn antenna was substituted in place of the EUT and was driven by a signal generator.

8. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission.

9. Taking the record of output power at antenna port.

10. Repeat step 7 to step 8 for another polarization.

11. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

= P(W) - [43 + 10log(P)] (dB)

 $= [30 + 10\log(P)] (dBm) - [43 + 10\log(P)] (dB)$ 

= -13dBm

For Band 7: The limit line is derived from 55 + 10log(P)dB below the transmitter power P(Watts) = [30 + 10log(P)] (dBm) - [55 + 10log(P)] (dB) = -25dBm EIRP (dBm) = S.G. Power – Tx Cable Loss + Tx Antenna Gain ERP (dBm) = EIRP - 2.15



# 9.1.4 TEST RESULTS

# LTE BAND 4

LTE Band 4 / 1.4MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest										
	S G.Lev	Apt(dBi)		PMea	Limit	Margin	Polarity			
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Fulanty			
3422.31	-33.79	12.90	12.56	-33.45	-13.00	-20.45	Н			
5133.42	-34.81	13.10	12.46	-34.17	-13.00	-21.17	Н			
6844.75	-33.23	12.33	21.13	-42.03	-13.00	-29.03	Н			
3422.31	-35.58	12.90	12.76	-35.44	-13.00	-22.44	V			
5133.42	-34.36	13.10	16.32	-37.58	-13.00	-24.58	V			
6844.75	-32.81	12.33	21.13	-41.61	-13.00	-28.61	V			
LTE Band 4 / 1	.4MHz / QF	PSK / RB S	ize 1 Offse	et 0/ The W	orst Test R	esults for	Middle			
	S G.Lev			PMea	Limit	Margin	Delerity			
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity			
3465.85	-34.31	12.80	12.56	-34.07	-13.00	-21.07	Н			
5199.22	-35.08	13.10	12.46	-34.44	-13.00	-21.44	Н			
6931.86	-32.92	12.33	21.13	-41.72	-13.00	-28.72	Н			
3465.85	-34.64	12.80	12.76	-34.60	-13.00	-21.60	V			
5199.22	-34.79	13.10	16.32	-38.01	-13.00	-25.01	V			
6931.86	-32.29	12.33	21.13	-41.09	-13.00	-28.09	V			
LTE Band 4 / 1.	.4MHz / QP	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for I	Highest			
Frequency(MHz)	S G.Lev	Ant(dBi)	Loco	PMea	Limit	Margin	Polarity			
Frequency(MHZ)	(dBm)	Ani(ubi)	Loss	(dBm)	(dBm)	(dB)	Folanty			
3508.73	-34.85	12.61	12.56	-34.80	-13.00	-21.80	Н			
5262.16	-35.04	13.12	12.46	-34.38	-13.00	-21.38	Н			
7016.23	-33.11	12.32	21.13	-41.92	-13.00	-28.92	Н			
3508.73	-35.71	12.61	12.76	-35.86	-13.00	-22.86	V			
5262.16	-33.81	13.12	16.32	-37.01	-13.00	-24.01	V			
7016.23	-32.71	12.32	21.13	-41.52	-13.00	-28.52	V			

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 4 / 3	3MHz / QP	SK / RB Siz	ze 1 Offset	0/ The Wo	orst Test Re	sults for L	owest
Frequency(MHz)	S G.Lev	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity
Fiequency(MHZ)	(dBm)	Ani(ubi)	L055	(dBm)	(dBm)	(dB)	Folanty
3424.19	-33.86	12.90	12.56	-33.52	-13.00	-20.52	Н
5136.52	-34.43	13.10	12.46	-33.79	-13.00	-20.79	н
6848.72	-32.17	12.33	21.13	-40.97	-13.00	-27.97	н
3424.19	-35.95	12.90	12.76	-35.81	-13.00	-22.81	V
5136.52	-33.94	13.10	16.32	-37.16	-13.00	-24.16	V
6848.72	-31.76	12.33	21.13	-40.56	-13.00	-27.56	V
LTE Band 4 /	3MHz / QP	SK / RB Siz	ze 1 Offset	t 0/ The Wo	orst Test Re	esults for N	Middle
	S G.Lev		1	PMea	Limit	Margin	Delerity
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3465.81	-33.53	12.80	12.56	-33.29	-13.00	-20.29	Н
5199.22	-35.03	13.10	12.46	-34.39	-13.00	-21.39	н
6932.28	-32.15	12.33	21.13	-40.95	-13.00	-27.95	Н
3465.81	-34.83	12.80	12.76	-34.79	-13.00	-21.79	V
5199.22	-33.94	13.10	16.32	-37.16	-13.00	-24.16	V
6932.28	-32.49	12.33	21.13	-41.29	-13.00	-28.29	V
LTE Band 4 / 3	BMHz / QPS	SK / RB Siz	e 1 Offset	0/ The Wo	orst Test Re	sults for H	lighest
	S G.Lev		1.000	PMea	Limit	Margin	Delerity
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3506.33	-33.86	12.61	12.56	-33.81	-13.00	-20.81	Н
5262.42	-34.11	13.12	12.46	-33.45	-13.00	-20.45	Н
7013.13	-32.45	12.32	21.13	-41.26	-13.00	-28.26	Н
3506.33	-35.80	12.61	12.76	-35.95	-13.00	-22.95	V
5262.42	-34.99	13.12	16.32	-38.19	-13.00	-25.19	V
7013.13	-32.02	12.32	21.13	-40.83	-13.00	-27.83	V

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line. Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 4 /	5MHz / QP	SK / RB Siz	e 1 Offset	0/ The Wo	orst Test Re	sults for L	owest
Frequency(MHz)	S G.Lev	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity
, , ,	(dBm)	. ,		(dBm)	(dBm)	(dB)	
3426.39	-34.44	12.90	12.56	-34.10	-13.00	-21.10	Н
5139.43	-34.53	13.10	12.46	-33.89	-13.00	-20.89	Н
6852.85	-33.07	12.33	21.13	-41.87	-13.00	-28.87	Н
3426.39	-35.00	12.90	12.76	-34.86	-13.00	-21.86	V
5139.43	-34.04	13.10	16.32	-37.26	-13.00	-24.26	V
6852.85	-31.84	12.33	21.13	-40.64	-13.00	-27.64	V
LTE Band 4 /	5MHz / QP	SK / RB Siz	ze 1 Offset	0/ The Wo	orst Test Re	esults for N	liddle
	S G.Lev	Anot(dDi)		PMea	Limit	Margin	Delerity
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3465.77	-33.88	12.80	12.56	-33.64	-13.00	-20.64	Н
5198.92	-35.02	13.10	12.46	-34.38	-13.00	-21.38	Н
6931.98	-32.44	12.33	21.13	-41.24	-13.00	-28.24	Н
3465.77	-35.91	12.80	12.76	-35.87	-13.00	-22.87	V
5198.92	-33.82	13.10	16.32	-37.04	-13.00	-24.04	V
6931.98	-31.80	12.33	21.13	-40.60	-13.00	-27.60	V
LTE Band 4 / 5	5MHz / QPS	SK / RB Siz	e 1 Offset	0/ The Wo	orst Test Re	sults for H	lighest
	S G.Lev	Anot(dDi)		PMea	Limit	Margin	Delerity
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3506.44	-34.46	12.61	12.56	-34.41	-13.00	-21.41	Н
5262.20	-35.41	13.12	12.46	-34.75	-13.00	-21.75	Н
7012.85	-33.53	12.32	21.13	-42.34	-13.00	-29.34	Н
3506.44	-35.54	12.61	12.76	-35.69	-13.00	-22.69	V
5262.20	-34.05	13.12	16.32	-37.25	-13.00	-24.25	V
7012.85	-32.08	12.32	21.13	-40.89	-13.00	-27.89	V

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line. Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 4 / 10MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest									
	S G.Lev			PMea	Limit	Margin	Lowest		
Frequency(MHz)		Ant(dBi)	Loss				Polarity		
	(dBm)			(dBm)	(dBm)	(dB)			
3436.08	-34.02	12.90	12.56	-33.68	-13.00	-20.68	Н		
5154.48	-34.12	13.10	12.46	-33.48	-13.00	-20.48	Н		
6872.95	-33.34	12.33	21.13	-42.14	-13.00	-29.14	Н		
3436.08	-35.70	12.90	12.76	-35.56	-13.00	-22.56	V		
5154.48	-33.84	13.10	16.32	-37.06	-13.00	-24.06	V		
6872.95	-32.07	12.33	21.13	-40.87	-13.00	-27.87	V		
LTE Band 4 / 1	0MHz / QF	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for	Middle		
	S G.Lev	Ant(dDi)		PMea	Limit	Margin	Delevite		
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity		
3466.06	-34.19	12.80	12.56	-33.95	-13.00	-20.95	Н		
5199.07	-35.41	13.10	12.46	-34.77	-13.00	-21.77	Н		
6932.24	-33.18	12.33	21.13	-41.98	-13.00	-28.98	Н		
3466.06	-35.68	12.80	12.76	-35.64	-13.00	-22.64	V		
5199.07	-35.21	13.10	16.32	-38.43	-13.00	-25.43	V		
6932.24	-32.16	12.33	21.13	-40.96	-13.00	-27.96	V		
LTE Band 4 / 1	0MHz / QP	SK / RB Siz	ze 1 Offset	t 0/ The Wo	orst Test Re	esults for H	lighest		
	S G.Lev	Apt(dDi)		PMea	Limit	Margin	Delority		
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity		
3494.49	-33.64	12.61	12.56	-33.59	-13.00	-20.59	Н		
5241.45	-34.59	13.12	12.46	-33.93	-13.00	-20.93	Н		
6987.88	-33.48	12.32	21.13	-42.29	-13.00	-29.29	Н		
3494.49	-34.68	12.61	12.76	-34.83	-13.00	-21.83	V		
5241.45	-34.32	13.12	16.32	-37.52	-13.00	-24.52	V		
6987.88	-33.00	12.32	21.13	-41.81	-13.00	-28.81	V		

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 4 / 15MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest										
	S G.Lev			PMea	Limit	Margin				
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity			
3436.40	-33.57	12.90	12.56	-33.23	-13.00	-20.23	Н			
5154.27	-34.48	13.10	12.46	-33.84	-13.00	-20.84	Н			
6872.68	-33.12	12.33	21.13	-41.92	-13.00	-28.92	Н			
3436.40	-35.86	12.90	12.76	-35.72	-13.00	-22.72	V			
5154.27	-33.92	13.10	16.32	-37.14	-13.00	-24.14	V			
6872.68	-32.12	12.33	21.13	-40.92	-13.00	-27.92	V			
LTE Band 4 /	5MHz / QP	SK / RB Siz	ze 1 Offset	: 0/ The Wo	orst Test Re	esults for N	liddle			
	S G.Lev (dBm)	S G.Lev		PMea	Limit	Margin	Dolority			
Frequency(MHz)		Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity			
3466.25	-34.81	12.80	12.56	-34.57	-13.00	-21.57	Н			
5199.16	-34.12	13.10	12.46	-33.48	-13.00	-20.48	Н			
6931.80	-33.17	12.33	21.13	-41.97	-13.00	-28.97	Н			
3466.25	-35.65	12.80	12.76	-35.61	-13.00	-22.61	V			
5199.16	-35.00	13.10	16.32	-38.22	-13.00	-25.22	V			
6931.80	-31.98	12.33	21.13	-40.78	-13.00	-27.78	V			
LTE Band 4 / 5	5MHz / QPS	SK / RB Siz	e 1 Offset	0/ The Wo	orst Test Re	sults for H	ighest			
	S G.Lev	Apt(dDi)		PMea	Limit	Margin	Delority			
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity			
3494.44	-33.51	12.61	12.56	-33.46	-13.00	-20.46	Н			
5242.23	-34.84	13.12	12.46	-34.18	-13.00	-21.18	Н			
6989.28	-32.31	12.32	21.13	-41.12	-13.00	-28.12	Н			
3494.44	-35.22	12.61	12.76	-35.37	-13.00	-22.37	V			
5242.23	-34.20	13.12	16.32	-37.40	-13.00	-24.40	V			
6989.28	-31.75	12.32	21.13	-40.56	-13.00	-27.56	V			

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 4 / 2	0MHz / QP	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for l	Lowest
	S G.Lev		1	PMea	Limit	Margin	Delevite
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3440.10	-34.77	12.90	12.56	-34.43	-13.00	-21.43	Н
5160.25	-35.37	13.10	12.46	-34.73	-13.00	-21.73	Н
6880.64	-32.66	12.33	21.13	-41.46	-13.00	-28.46	Н
3440.10	-35.17	12.90	12.76	-35.03	-13.00	-22.03	V
5160.25	-34.78	13.10	16.32	-38.00	-13.00	-25.00	V
6880.64	-32.19	12.33	21.13	-40.99	-13.00	-27.99	V
LTE Band 4 / 1	0MHz / QF	PSK / RB Si	ize 1 Offse	t 0/ The W	orst Test R	esults for	Middle
	S G.Lev		1	PMea	Limit	Margin	Delerity
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3466.21	-34.81	12.80	12.56	-34.57	-13.00	-21.57	Н
5199.17	-34.48	13.10	12.46	-33.84	-13.00	-20.84	Н
6932.15	-32.55	12.33	21.13	-41.35	-13.00	-28.35	Н
3466.21	-34.84	12.80	12.76	-34.80	-13.00	-21.80	V
5199.17	-34.50	13.10	16.32	-37.72	-13.00	-24.72	V
6932.15	-32.09	12.33	21.13	-40.89	-13.00	-27.89	V
LTE Band 4 / 1	0MHz / QP	SK / RB Siz	ze 1 Offse	t 0/ The Wo	orst Test Re	esults for H	Highest
Frequency(MHz)	S G.Lev	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity
Frequency(IVIHZ)	(dBm)	Апциы)	LUSS	(dBm)	(dBm)	(dB)	Polarity
3490.59	-33.54	12.61	12.56	-33.49	-13.00	-20.49	Н
5235.43	-34.79	13.12	12.46	-34.13	-13.00	-21.13	Н
6979.90	-32.50	12.32	21.13	-41.31	-13.00	-28.31	Н
3490.59	-35.86	12.61	12.76	-36.01	-13.00	-23.01	V
5235.43	-35.00	13.12	16.32	-38.20	-13.00	-25.20	V
6979.90	-32.42	12.32	21.13	-41.23	-13.00	-28.23	V

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line. Test is divided into three directions, X/Y/Z. X pattern for the worst.

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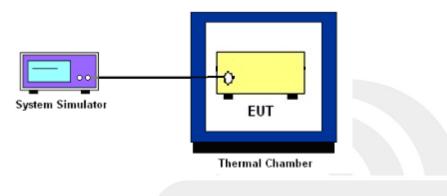
# **10. FREQUENCY STABILITY**

#### 10.1 DESCRIPTION OF FREQUENCY STABILITY MEASUREMENT

#### 10.1.1 MEASUREMENT METHOD

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within  $\pm 0.00025\%$  ( $\pm 2.5$ ppm) of the center frequency.

#### 10.1.2 Test Setup



# 10.1.3 TEST PROCEDURES FOR TEMPERATURE VARIATION

1. The EUT was set up in the thermal chamber and connected with the system simulator.

With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute.
 With power OFF, the temperature was raised in 10°C step up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute.

# 10.1.4 TEST PROCEDURES FOR VOLTAGE VARIATION

1. The testing follows FCC KDB 971168 v02r02 Section 9.0.

2. The EUT was placed in a temperature chamber at 25±5° C and connected with the system simlator.

3. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.

4. The variation in frequency was measured for the worst case.



# **10.1.4 MEASUREMENT RESULT**

#### LTE BAND 4

	LTE Band 4 (QPSK) / 1733MHz / BW10M										
Temperature	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result						
(°C)	(Volt)	(Hz)	(ppm)								
50		23.59	0.014								
40		32.45	0.019								
30		19.02	0.011								
20	Normal Vol-	26.06	0.015	- 							
10		28.96	0.017								
0	tage	14.94	0.009		PASS						
-10		14.05	0.008	- 2.5ppm	FA00						
-20		29.26	0.017								
-30		12.30	0.007								
25	Maximum	15.74	0.009								
20	Voltage	10.74	0.009								
25	BEP	36.18	0.021								

	LTE Band 4 (QPSK) / 1733MHz / BW20M											
Temperature (°C)	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result							
	(Volt)	(Hz)	(ppm)									
50		36.07	0.021									
40		28.62	0.017									
30		19.04	0.011									
20		13.58	0.008									
10	Normal Vol-	31.41	0.018									
0	tage	14.78	0.009	2.5ppm	PASS							
-10		35.09	0.020	2.5ppm	FAGO							
-20		26.65	0.015									
-30		15.63	0.009									
25	Maximum	30.61	0.018									
25	Voltage	30.01	0.010									
25	BEP	18.40	0.011									

Note:

1. Normal Voltage = 3.7V. ; Battery End Point (BEP) = 3.5 V.; Maximum Voltage = 4.2 V

2. Note: The frequency fundamental emissions stay within the authorized frequency block based on

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the frequency deviation measured is small.

# PHOTOS OF TEST SETUP

RADIATED SPURIOUS EMISSION





\* \* \* \* \* END OF THE REPORT \* \* \* \*

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